

N-Channel 700 V(D-S) Supper Junction Power MOSFET

| PRODUCT SUMMARY | | | | | |
|---------------------------------|------------------------|-----|--|--|--|
| V _{DS} (V) | 700 | | | | |
| $R_{DS(on)}\left(\Omega\right)$ | V _{GS} = 10 V | 2.4 | | | |
| Q _g (Max.) (nC) | 15 | | | | |
| Q _{gs} (nC) | 3 | | | | |
| Q _{gd} (nC) | 6 | | | | |
| Configuration | Single | | | | |

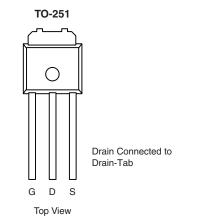
FEATURES

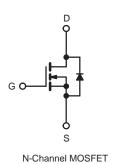
• Low Gate Charge Q_g Results in Simple Drive Requirement



COMPLIANT

- RoHS • Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC





| ABSOLUTE MAXIMUM RATINGS $T_C = 25 \text{ °C}$, unless otherwise noted | | | | | | |
|--|-----------------------------------|---|-----------------------------------|---------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | V _{DS} | 700 | - V | | |
| Gate-Source Voltage | | | V _{GS} | ± 30 | v | |
| Continuous Drain Currente | V _{GS} at 10 V | $T_C = 25 \degree C$ $T_C = 100 \degree C$ | | 2.0 | | |
| Continuous Drain Current | V _{GS} at 10 V | $T_C = 100 \ ^\circ C$ | Ι _D | 1.6 | A | |
| Pulsed Drain Current ^a | Pulsed Drain Current ^a | | | 8.0 | | |
| Linear Derating Factor | | | | 0.48 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 165 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 2 | A | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 4 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | PD | 60 | W | |
| Peak Diode Recovery dV/dtc | | | dV/dt | 2.8 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 150 | °C | |
| Soldering Recommendations (Peak Temperature) ^d | for 10 s | | | 300 | | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf ⋅ in | |
| | | | | 1.1 | N · m | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting $T_J = 25$ °C, L = 24 mH, $R_G = 25 \Omega$, $I_{AS} = 3.2$ A (see fig. 12).

c. $I_{SD} \le 3.2$ Å, $dI/dt \le 90$ Å/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.

| J. | 3 | ® VBsemi |
|----|------|-------------|
| W | ww.\ | /Bsemi.com |

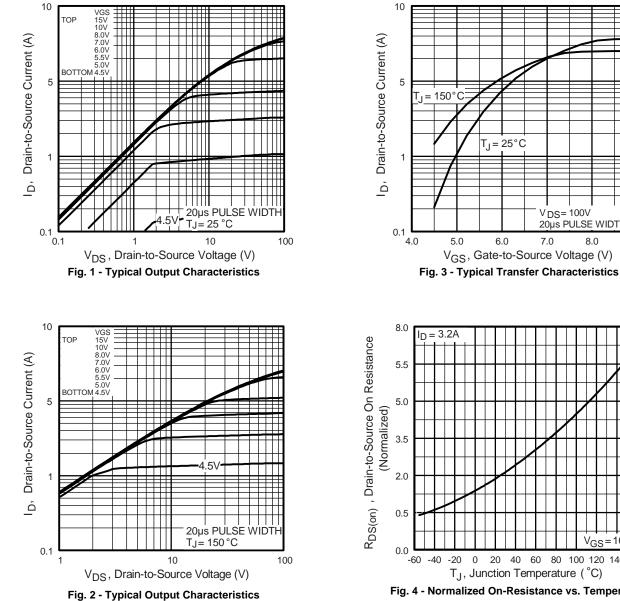
| THERMAL RESISTANCE RA | TINGS | | | | | | | |
|--|-----------------------|---|--|----------------------------------|------|------------------|-------|-------|
| PARAMETER | SYMBOL | TYP | | MAX. | MAX. | | UNIT | |
| Maximum Junction-to-Ambient | R _{thJA} | - | | 65 | | | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - 2.1 | | | °C/W | | | |
| | | | | | | | | |
| SPECIFICATIONS $T_J = 25 \ ^{\circ}C$, | unless otherv | wise noted | | | | | | |
| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT | |
| Static | | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | = 0 V, I _D = 2 | 50 µA | 700 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | e to 25 °C, I | _D = 1 mA ^d | - | 670 | - | mV/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | $V_{GS}, I_D = 2$ | 50 µA | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | , | $V_{\rm GS} = \pm 30$ V | V | - | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = | 700 V, V _{GS} | s = 0 V | - | - | 25 | μA |
| | USS | V _{DS} = 560 V | $V_{\rm GS} = 0 V$ | , T _J = 125 °C | - | - | 250 | |
| Drain-Source On-State Resistance | R _{DS(on)} | $V_{GS} = 10 V$ | I _D | = 3.1 A ^b | - | 2.4 | - | Ω |
| Forward Transconductance | 9 _{fs} | V _{DS} : | $V_{DS} = 50 \text{ V}, \text{ I}_{D} = 3.1 \text{ A}$ | | 3.9 | - | - | S |
| Dynamic | | | | | | | | |
| Input Capacitance | C _{iss} | | V _{GS} = 0 V, | | - | 330 | - | |
| Output Capacitance | C _{oss} | | $V_{DS} = 25 V,$ | | - | 40 | - | |
| Reverse Transfer Capacitance | C _{rss} | f = 1. | 0 MHz, see | tig. 5 | - | 5.0 | - | - pF |
| Output Capacitance | 6 | | V _{DS} = 1.0 | V, f = 1.0 MHz | - | 912 | - | |
| Oulput Capacitance | C _{oss} | $V_{GS} = 0 V$ | V _{DS} = 560 V, f = 1.0 MHz | - | 48 | - | | |
| Effective Output Capacitance | Coss eff. | | $V_{DS} = 0$ |) V to 560 V ^c | - | 84 | - | 1 |
| Total Gate Charge | Qg | | | | - | - | 15 | nC |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | | A, V _{DS} = 400 V | - | - | 3 | |
| Gate-Drain Charge | Q _{gd} | - | see fig | J. 6 and 13 ^b | - | - | 6 | |
| Turn-On Delay Time | t _{d(on)} | | | | - | 14 | - | |
| Rise Time | tr | | = 325 V, I _D = | | - | 20 | - | 1 |
| Turn-Off Delay Time | t _{d(off)} | $R_G = 9.1 \Omega, R_D = 62 \Omega,$ see fig. 10^{b} | | - | 34 | - | - ns | |
| Fall Time | t _f | | | - | 18 | - | | |
| Drain-Source Body Diode Characteristic | cs | | | | | | | |
| Continuous Source-Drain Diode Current | ١ _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 4 | Δ | |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 21 | A | |
| Body Diode Voltage | V _{SD} | $T_J = 25 \text{ °C}, I_S = 3.2 \text{ A}, V_{GS} = 0 \text{ V}^b$ | | - | - | 1.5 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | | | | - | 493 | 739 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | - T _J = 25 °C, I _F = 3.2 A, dI/dt = 100 A/µs ^b | | - | 2.1 | 3.2 | μC | |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | L _D) | | |

Notes

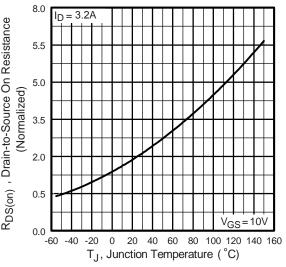
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width $\leq 300 \ \mu$ s; duty cycle $\leq 2 \ \%$. c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS}. d. t = 60 s, f = 60 Hz.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 $T_J = 25^{\circ}C$

6.0

5.0

V_{DS}= 100V

7.0

20µs PULSE WIDTH

8.0

9.0

Fig. 4 - Normalized On-Resistance vs. Temperature

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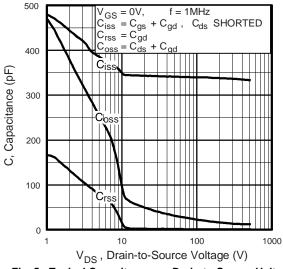


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

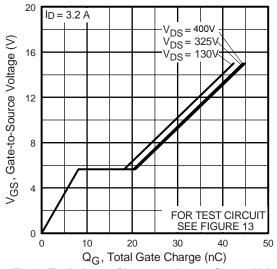


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

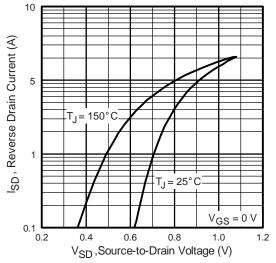
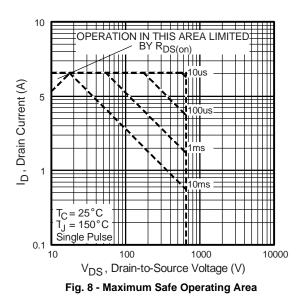


Fig. 7 - Typical Source-Drain Diode Forward Voltage



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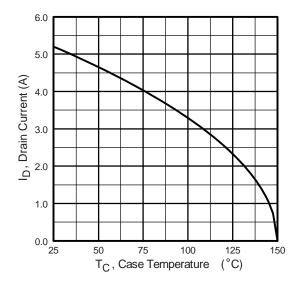


Fig. 9 - Maximum Drain Current vs. Case Temperature

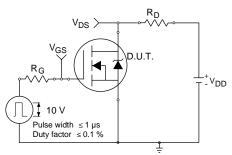


Fig. 10a - Switching Time Test Circuit

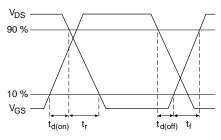
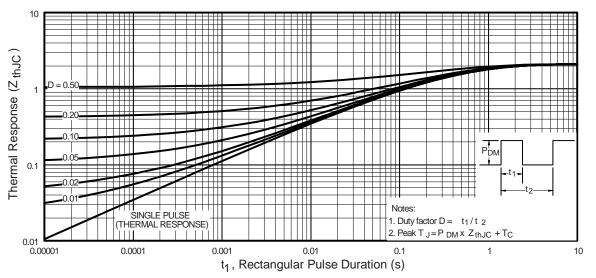


Fig. 10b - Switching Time Waveforms





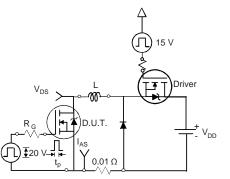
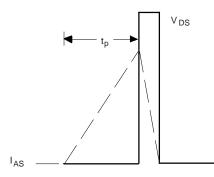
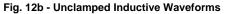


Fig. 12a - Unclamped Inductive Test Circuit







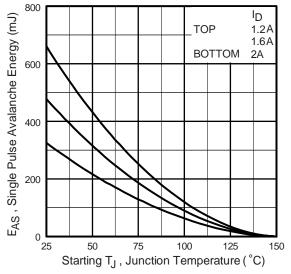


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

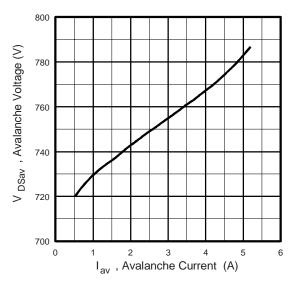


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

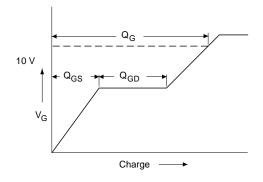


Fig. 13a - Basic Gate Charge Waveform

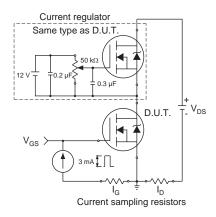
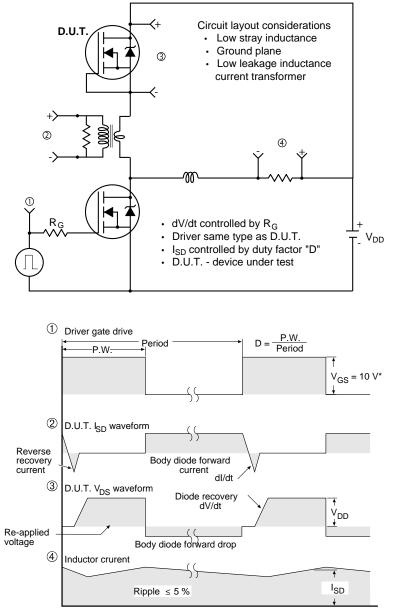


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit

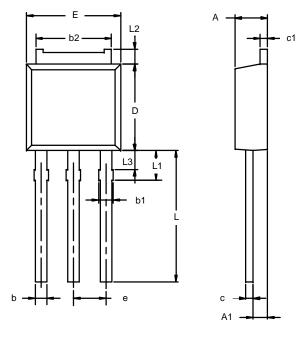
* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel

VBZF2N70S



TO-251AA



| | MILLIMETERS | | INCHES | | |
|-----|-------------|------|-----------|-------|--|
| Dim | Min | Max | Min | Max | |
| Α | 2.21 | 2.38 | 0.087 | 0.094 | |
| A1 | 0.89 | 1.14 | 0.035 | 0.045 | |
| b | 0.71 | 0.89 | 0.028 | 0.035 | |
| b1 | 0.76 | 1.14 | 0.030 | 0.045 | |
| b2 | 5.23 | 5.43 | 0.206 | 0.214 | |
| С | 0.46 | 0.58 | 0.018 | 0.023 | |
| c1 | 0.46 | 0.58 | 0.018 | 0.023 | |
| D | 5.97 | 6.22 | 0.235 | 0.245 | |
| E | 6.48 | 6.73 | 0.255 | 0.265 | |
| е | 2.28 | BSC | 0.090 BSC | | |
| L | 3.89 | 9.53 | 0.153 | 0.375 | |
| L1 | 1.91 | 2.28 | 0.075 | 0.090 | |
| L2 | 0.89 | 1.27 | 0.035 | 0.050 | |
| L3 | 1.15 | 1.52 | 0.045 | 0.060 | |

Note: Dimension L3 is for reference only.



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